Se	ea	rcl	h /	V	ot	es
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/615,416	WISHART ET AL.
Examiner	Art Unit
Pablo Whaley	1631

	SEAR	CHED	
Class	Subclass	Date	Examiner
	-		

INI	ERFERENC	E SEARCI	HED
Class	Subclass	Date	Examiner
-			

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Google Scholar: drift effects, NMR, spectral data correction	3/12/2007	PW
EAST: See attached	3/8/2007	PW
Priority: Considered	3/8/2007	PW
Inventor Search: PALM	3/8/2007	PW